



## FAST CMOS OCTAL TRANSPARENT LATCH

**IDT74FCT573A/C**

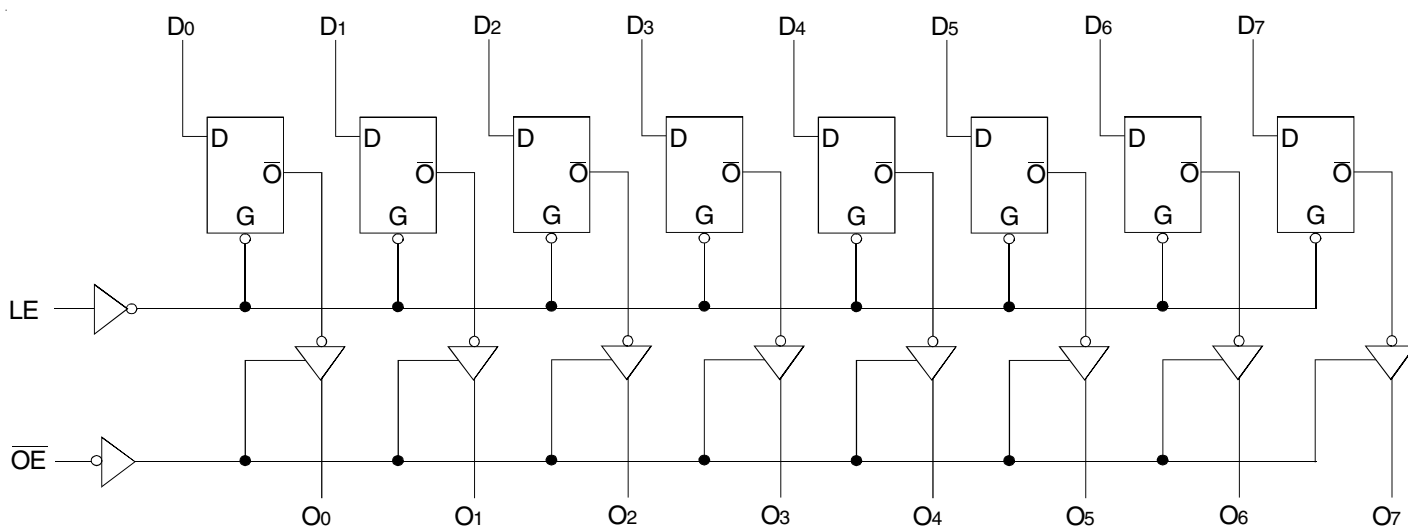
### FEATURES:

- IDT74FCT573A up to 30% faster than FAST
- IDT74FCT573C up to 50% faster than FAST
- Equivalent to FAST output drive over full temperature and voltage supply extremes
- $I_{OL} = 48\text{mA}$
- CMOS power levels (1mW typ. static)
- Octal transparent latch with 3-state output control
- Available in SOIC package

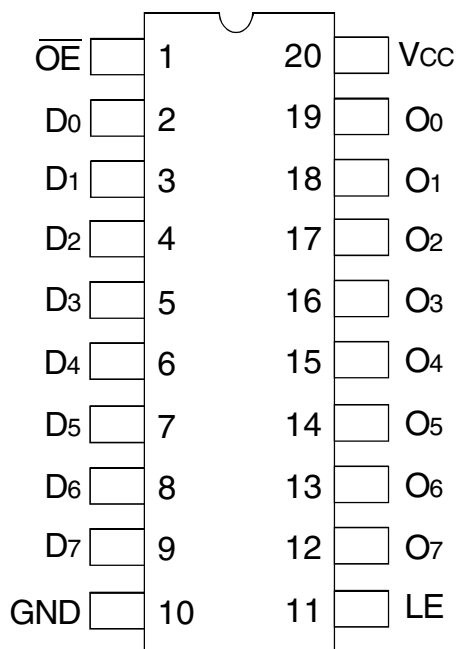
### DESCRIPTION:

The FCT573 is an octal transparent latch built using an advanced dual metal CMOS technology. These octal latches have 3-state outputs and are intended for bus oriented applications. The flip-flops appear transparent to the data when Latch Enable (LE) is high. When LE is low, the data that meets the set-up time is latched. Data appears on the bus when the Output Enable ( $\overline{OE}$ ) is low. When  $\overline{OE}$  is high, the bus output is in the high-impedance state.

### FUNCTIONAL BLOCK DIAGRAM



## PIN CONFIGURATION



## ABSOLUTE MAXIMUM RATINGS<sup>(1)</sup>

| Symbol                           | Description                          | Max                     | Unit |
|----------------------------------|--------------------------------------|-------------------------|------|
| V <sub>TERM</sub> <sup>(2)</sup> | Terminal Voltage with Respect to GND | −0.5 to +7              | V    |
| V <sub>TERM</sub> <sup>(3)</sup> | Terminal Voltage with Respect to GND | −0.5 to V <sub>CC</sub> | V    |
| T <sub>A</sub>                   | Operating Temperature                | 0 to +70                | °C   |
| T <sub>BIAS</sub>                | Temperature under BIAS               | −55 to +125             | °C   |
| T <sub>STG</sub>                 | Storage Temperature                  | −55 to +125             | °C   |
| P <sub>T</sub>                   | Power Dissipation                    | 0.5                     | W    |
| I <sub>OUT</sub>                 | DC Output Current                    | 120                     | mA   |

### NOTES:

- Stresses greater than those listed under ABSOLUTE MAXIMUM RATINGS may cause permanent damage to the device. This is a stress rating only and functional operation of the device at these or any other conditions above those indicated in the operational sections of this specification is not implied. Exposure to absolute maximum rating conditions for extended periods may affect reliability. No terminal voltage may exceed V<sub>CC</sub> by +0.5V unless otherwise noted.
- Input and V<sub>CC</sub> terminals only.
- Output and I/O terminals only.

## CAPACITANCE (T<sub>A</sub> = +25°C, F = 1.0MHz)

| Symbol           | Parameter <sup>(1)</sup> | Conditions            | Typ. | Max. | Unit |
|------------------|--------------------------|-----------------------|------|------|------|
| C <sub>IN</sub>  | Input Capacitance        | V <sub>IN</sub> = 0V  | 6    | 10   | pF   |
| C <sub>OUT</sub> | Output Capacitance       | V <sub>OUT</sub> = 0V | 8    | 12   | pF   |

### NOTE:

- This parameter is measured at characterization but not tested.

## PIN DESCRIPTION

| Pin Names       | Description                      |
|-----------------|----------------------------------|
| Dx              | Data Inputs                      |
| LE              | Latch Enable Input (Active HIGH) |
| $\overline{OE}$ | Output Enable Input (Active LOW) |
| Ox              | 3-State Outputs                  |

## FUNCTION TABLE<sup>(1)</sup>

| Inputs |    |                 | Outputs |
|--------|----|-----------------|---------|
| Dx     | LE | $\overline{OE}$ | Ox      |
| H      | H  | L               | H       |
| L      | H  | L               | L       |
| X      | X  | X               | Z       |

### NOTE:

- H = HIGH Voltage Level  
X = Don't Care  
L = LOW Voltage Level  
Z = High Impedance

## DC ELECTRICAL CHARACTERISTICS OVER OPERATING RANGE

Following Conditions Apply Unless Otherwise Specified:  $V_{LC} = 0.2V$ ;  $V_{HC} = V_{CC} - 0.2V$

Commercial:  $T_A = 0^\circ C$  to  $+70^\circ C$ ,  $V_{CC} = 5.0V \pm 5\%$

| Symbol    | Parameter                                    | Test Conditions <sup>(1)</sup>                                      |                      | Min.     | Typ. <sup>(2)</sup> | Max.                    | Unit    |
|-----------|----------------------------------------------|---------------------------------------------------------------------|----------------------|----------|---------------------|-------------------------|---------|
| $V_{IH}$  | Input HIGH Level                             | Guaranteed Logic HIGH Level                                         |                      | 2        | —                   | —                       | V       |
| $V_{IL}$  | Input LOW Level                              | Guaranteed Logic LOW Level                                          |                      | —        | —                   | 0.8                     | V       |
| $I_{IH}$  | Input HIGH Current                           | $V_{CC} = \text{Max.}$                                              | $V_I = V_{CC}$       | —        | —                   | 5                       | $\mu A$ |
|           |                                              |                                                                     | $V_I = 2.7V$         | —        | —                   | 5 <sup>(4)</sup>        |         |
| $I_{IL}$  | Input LOW Current                            |                                                                     | $V_I = 0.5V$         | —        | —                   | -5 <sup>(4)</sup>       |         |
|           |                                              |                                                                     | $V_I = GND$          | —        | —                   | -5                      |         |
| $I_{OZH}$ | Off State (High Impedance)<br>Output Current | $V_{CC} = \text{Max.}$                                              | $V_O = V_{CC}$       | —        | —                   | 10                      | $\mu A$ |
|           |                                              |                                                                     | $V_O = 2.7V$         | —        | —                   | 10 <sup>(4)</sup>       |         |
| $I_{OZL}$ |                                              |                                                                     | $V_O = 0.5V$         | —        | —                   | -10 <sup>(4)</sup>      |         |
|           |                                              |                                                                     | $V_O = GND$          | —        | —                   | -10                     |         |
| $V_{IK}$  | Clamp Diode Voltage                          | $V_{CC} = \text{Min.}$ , $I_{IN} = -18mA$                           |                      | —        | -0.7                | -1.2                    | V       |
| $I_{OS}$  | Short Circuit Current                        | $V_{CC} = \text{Max.}$ , $V_O = GND$ <sup>(3)</sup>                 |                      | -60      | -120                | —                       | mA      |
| $V_{OH}$  | Output HIGH Voltage                          | $V_{CC} = 3V$ , $V_{IN} = V_{LC}$ or $V_{HC}$ , $I_{OH} = -32\mu A$ |                      | $V_{HC}$ | $V_{CC}$            | —                       | V       |
|           |                                              | $V_{CC} = \text{Min}$                                               | $I_{OH} = -300\mu A$ | $V_{HC}$ | $V_{CC}$            | —                       |         |
|           |                                              | $V_{IN} = V_{IH}$ or $V_{IL}$                                       | $I_{OH} = -15mA$     | 2.4      | 4.3                 | —                       |         |
| $V_{OL}$  | Output LOW Voltage                           | $V_{CC} = 3V$ , $V_{IN} = V_{LC}$ or $V_{HC}$ , $I_{OL} = 300\mu A$ |                      | —        | GND                 | $V_{LC}$                | V       |
|           |                                              | $V_{CC} = \text{Min}$                                               | $I_{OL} = 300\mu A$  | —        | GND                 | $V_{LC}$ <sup>(4)</sup> |         |
|           |                                              | $V_{IN} = V_{IH}$ or $V_{IL}$                                       | $I_{OL} = 48mA$      | —        | 0.3                 | 0.5                     |         |

### NOTES:

1. For conditions shown as Min. or Max., use appropriate value specified under Electrical Characteristics for the applicable device type.
2. Typical values are at  $V_{CC} = 5.0V$ ,  $+25^\circ C$  ambient and maximum loading.
3. Not more than one output should be tested at one time. Duration of the test should not exceed one second.
4. This parameter is guaranteed but not tested.

## POWER SUPPLY CHARACTERISTICS

$V_{LC} = 0.2V$ ;  $V_{HC} = V_{CC} - 0.2V$

| Symbol           | Parameter                                         | Test Conditions <sup>(1)</sup>                                                                                                                              |                                                                                 | Min. | Typ. <sup>(2)</sup> | Max.                | Unit       |
|------------------|---------------------------------------------------|-------------------------------------------------------------------------------------------------------------------------------------------------------------|---------------------------------------------------------------------------------|------|---------------------|---------------------|------------|
| I <sub>CC</sub>  | Quiescent Power Supply Current                    | V <sub>CC</sub> = Max.<br>V <sub>IN</sub> ≥ V <sub>HC</sub> ; V <sub>IN</sub> ≤ V <sub>LC</sub>                                                             |                                                                                 | —    | 0.2                 | 1.5                 | mA         |
| ΔI <sub>CC</sub> | Quiescent Power Supply Current<br>TTL Inputs HIGH | V <sub>CC</sub> = Max.<br>V <sub>IN</sub> = 3.4V <sup>(3)</sup>                                                                                             |                                                                                 | —    | 0.5                 | 2                   | mA         |
| I <sub>CCD</sub> | Dynamic Power Supply<br>Current <sup>(4)</sup>    | V <sub>CC</sub> = Max.<br>Outputs Open<br>$\overline{OE} = GND$<br>One Input Toggling<br>50% Duty Cycle                                                     | V <sub>IN</sub> ≥ V <sub>HC</sub><br>V <sub>IN</sub> ≤ V <sub>LC</sub>          | —    | 0.15                | 0.25                | mA/<br>MHz |
| I <sub>C</sub>   | Total Power Supply Current <sup>(6)</sup>         | V <sub>CC</sub> = Max.<br>Outputs Open<br>f <sub>i</sub> = 10MHz<br>50% Duty Cycle<br>$\overline{OE} = GND$<br>LE = V <sub>CC</sub><br>One Bit Toggling     | V <sub>IN</sub> ≥ V <sub>HC</sub><br>V <sub>IN</sub> ≤ V <sub>LC</sub><br>(FCT) | —    | 1.7                 | 4                   | mA         |
|                  |                                                   |                                                                                                                                                             | V <sub>IN</sub> = 3.4V<br>V <sub>IN</sub> = GND                                 | —    | 2                   | 5                   |            |
|                  |                                                   | V <sub>CC</sub> = Max.<br>Outputs Open<br>f <sub>i</sub> = 2.5MHz<br>50% Duty Cycle<br>$\overline{OE} = GND$<br>LE = V <sub>CC</sub><br>Eight Bits Toggling | V <sub>IN</sub> ≥ V <sub>HC</sub><br>V <sub>IN</sub> ≤ V <sub>LC</sub><br>(FCT) | —    | 3.2                 | 6.5 <sup>(5)</sup>  |            |
|                  |                                                   |                                                                                                                                                             | V <sub>IN</sub> = 3.4V<br>V <sub>IN</sub> = GND                                 | —    | 5.2                 | 14.5 <sup>(5)</sup> |            |

### NOTES:

1. For conditions shown as Min. or Max., use appropriate value specified under Electrical Characteristics for the applicable device type.

2. Typical values are at V<sub>CC</sub> = 5.0V, +25°C ambient.

3. Per TTL driven input (V<sub>IN</sub> = 3.4V). All other inputs at V<sub>CC</sub> or GND.

4. This parameter is not directly testable, but is derived for use in Total Power Supply Calculations.

5. Values for these conditions are examples of ΔI<sub>CC</sub> formula. These limits are guaranteed but not tested.

6. I<sub>C</sub> = I<sub>QUIESCENT</sub> + I<sub>INPUTS</sub> + I<sub>DYNAMIC</sub>

I<sub>C</sub> = I<sub>CC</sub> + ΔI<sub>CC</sub> D<sub>H</sub>N<sub>T</sub> + I<sub>CCD</sub> (f<sub>CP</sub>/2 + f<sub>i</sub>N<sub>i</sub>)

I<sub>CC</sub> = Quiescent Current

ΔI<sub>CC</sub> = Power Supply Current for a TTL High Input (V<sub>IN</sub> = 3.4V)

D<sub>H</sub> = Duty Cycle for TTL Inputs High

N<sub>T</sub> = Number of TTL Inputs at D<sub>H</sub>

I<sub>CCD</sub> = Dynamic Current caused by an Input Transition Pair (HLH or LHL)

f<sub>CP</sub> = Clock Frequency for register devices (zero for non-register devices)

f<sub>i</sub> = Input Frequency

N<sub>i</sub> = Number of Inputs at f<sub>i</sub>

All currents are in milliamps and all frequencies are in megahertz.

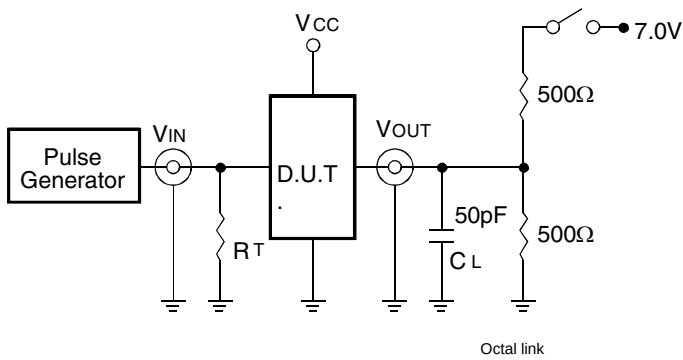
## SWITCHING CHARACTERISTICS OVER OPERATING RANGE

| Symbol                               | Parameter                         | Condition <sup>(1)</sup>                       | FCT573A             |      | FCT573C             |      | Unit |
|--------------------------------------|-----------------------------------|------------------------------------------------|---------------------|------|---------------------|------|------|
|                                      |                                   |                                                | Min. <sup>(2)</sup> | Max. | Min. <sup>(2)</sup> | Max. |      |
| t <sub>PLH</sub><br>t <sub>PHL</sub> | Propagation Delay<br>Dx to Ox     | C <sub>L</sub> = 50pF<br>R <sub>L</sub> = 500Ω | 1.5                 | 5.2  | 1.5                 | 4.2  | ns   |
| t <sub>PLH</sub><br>t <sub>PHL</sub> | Propagation Delay<br>LE to Ox     |                                                | 2                   | 8.5  | 2                   | 5.5  | ns   |
| t <sub>PZH</sub><br>t <sub>PZL</sub> | Output Enable Time                |                                                | 1.5                 | 6.5  | 1.5                 | 5.5  | ns   |
| t <sub>PHZ</sub><br>t <sub>PLZ</sub> | Output Disable Time               |                                                | 1.5                 | 5.5  | 1.5                 | 5    | ns   |
| t <sub>SU</sub>                      | Set-up Time HIGH or LOW, Dx to LE |                                                | 2                   | —    | 2                   | —    | ns   |
| t <sub>H</sub>                       | Hold Time HIGH or LOW, Dx to LE   |                                                | 1.5                 | —    | 1.5                 | —    | ns   |
| t <sub>w</sub>                       | LE Pulse Width HIGH               |                                                | 5                   | —    | 5                   | —    | ns   |

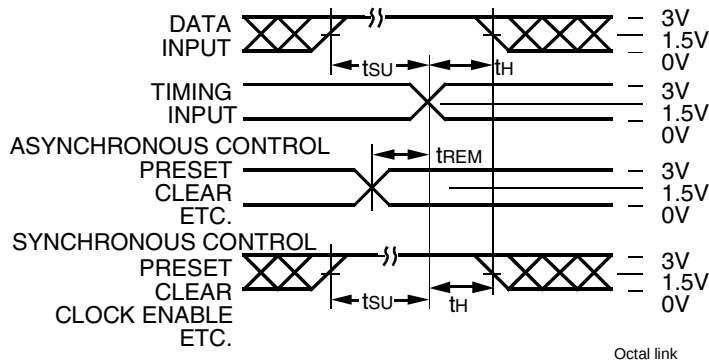
### NOTES:

1. See test circuit and waveforms.
2. Minimum limits are guaranteed but not tested on Propagation Delays.

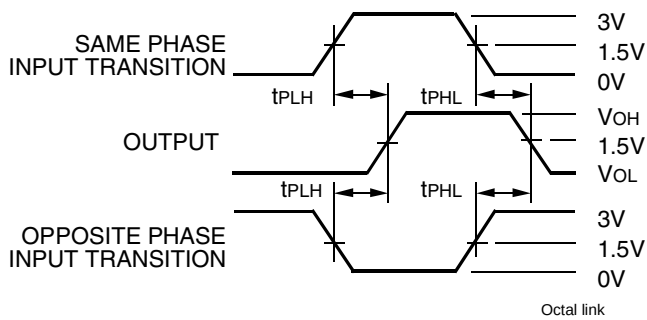
## TEST CIRCUITS AND WAVEFORMS



**Test Circuits for All Outputs**



**Set-Up, Hold, and Release Times**



**Propagation Delay**

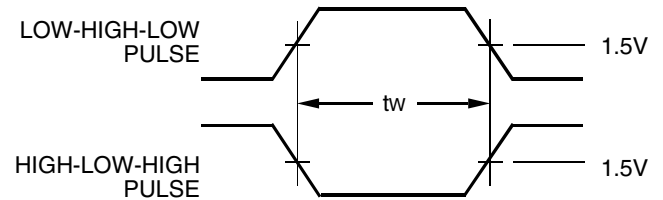
## SWITCH POSITION

| Test                                    | Switch |
|-----------------------------------------|--------|
| Open Drain<br>Disable Low<br>Enable Low | Closed |
| All Other Tests                         | Open   |

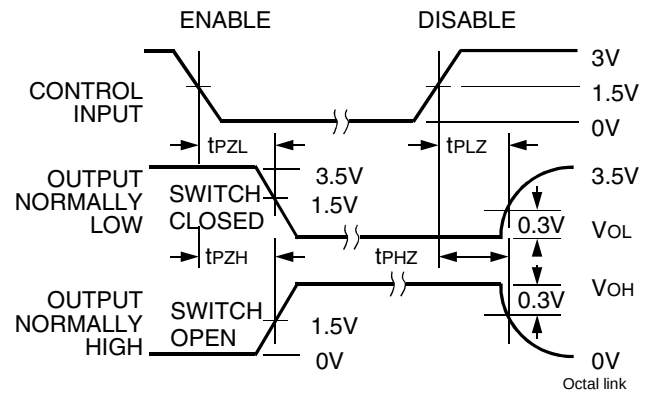
### DEFINITIONS:

CL = Load capacitance: includes jig and probe capacitance.

RT = Termination resistance: should be equal to ZOUT of the Pulse Generator.



**Pulse Width**

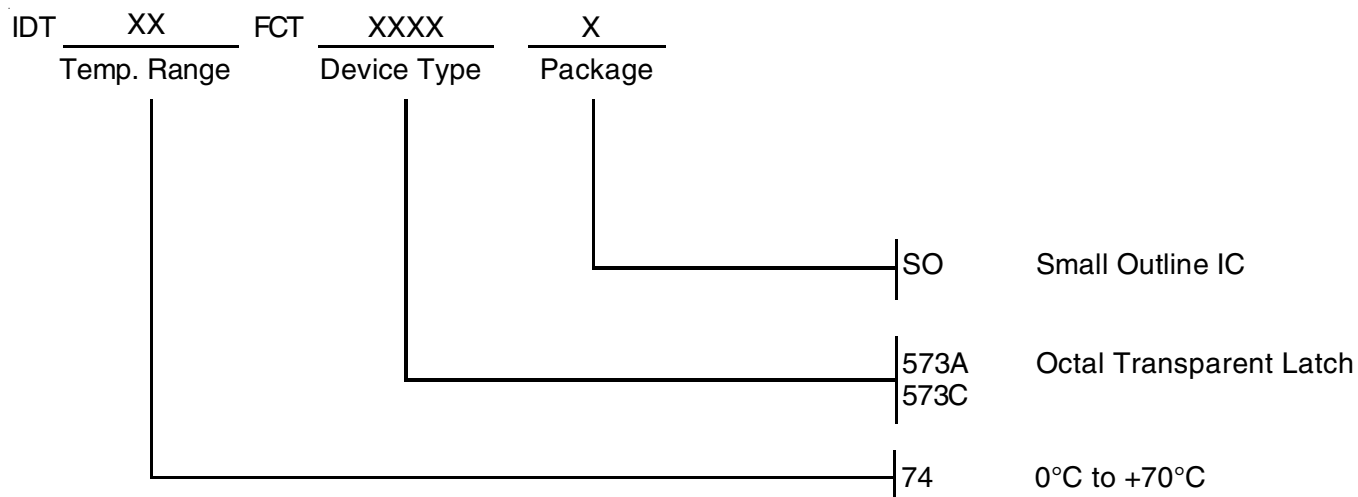


**Enable and Disable Times**

### NOTES:

- Diagram shown for input Control Enable-LOW and input Control Disable-HIGH.
- Pulse Generator for All Pulses: Rate  $\leq 1.0\text{MHz}$ ;  $Z_o \leq 50\Omega$ ;  $t_r \leq 2.5\text{ns}$ ;  $t_f \leq 2.5\text{ns}$ .

## ORDERING INFORMATION



**CORPORATE HEADQUARTERS**  
2975 Stender Way  
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